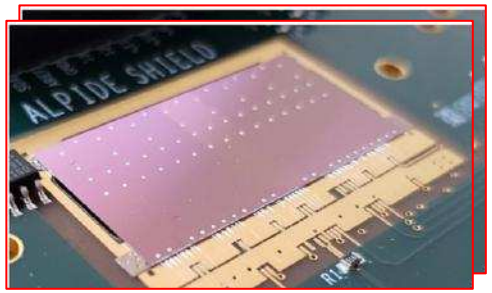
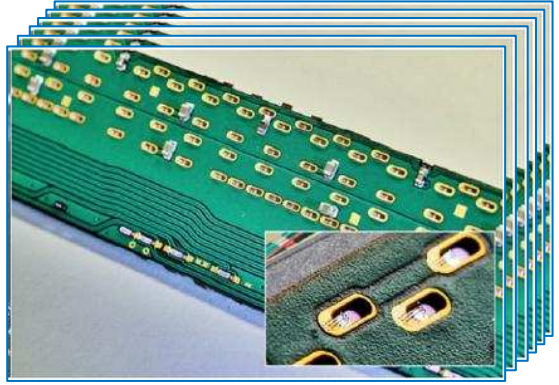


FPC test

chip test



HIC assembly

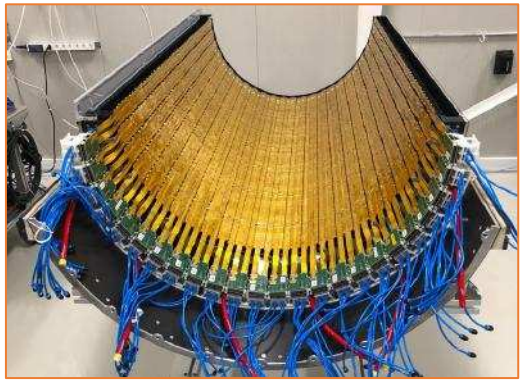
HIC characterization

CP and SF characterization

for OB: PB characterization

Stave assembly

Stave characterization



Half layer assembly

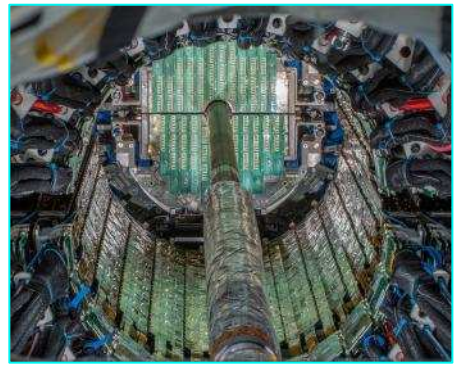
Half layer characterization

Half barrel assembly

Half barrel characterization

Installation

commissioning



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